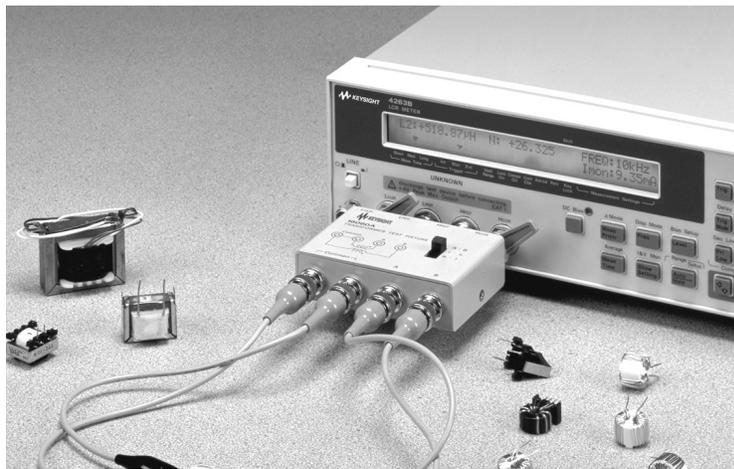


Keysight Technologies

Effective Multi-tap Transformer Measurement using a Scanner and the 4263B LCR Meter

Application Note





Introduction

With the progress of recent electronics equipment and digital networks, production amounts are increasing of the transformers which contribute to equipment miniaturization, low power dissipation and higher quality. Therefore, improvement of select estimate efficiency is required at the production line or incoming inspection. Noticed recently, improvement of estimation efficiency is required for pulse transformers which are used in LAN or ISDN digital networks, and for multi.-tap transformers with three or more pole taps, such as switching power transformers. This application note shows an effective multi-tap transformer measurement using a scanner and the 4263B LCR meter.

The 4263B Transformer Measurement Capability

The 4263B LCR meter is a low price instrument which measures the fundamental parameters of LCR components with speeds as fast as 25ms, at frequencies of 100, 120, 1k, 10k and 100kHz. In addition, with option 001, the 4263B measures turns ratio (N), mutual inductance (M) and dc resistance (DCR) which are required for transformer measurement. Figure 1 shows a 4263B simple block diagram for L, M, and DCR measurement.

For example, in the inductance-turns ratio (L-N) measurement, an ac voltage is applied at the Hcur terminal. Self-inductance value (L1) is calculated from the measured values of V1 and I1. Turns ratio (N) is automatically obtained from the ratio of measured values V1 and V2 (discriminating the polarity simultaneously).

In the dc resistance (of L-DCR) measurement, the applied voltage at the Hcur terminal is dc. Dc resistance value (DCR1) is calculated from the measured values V1 and I1.

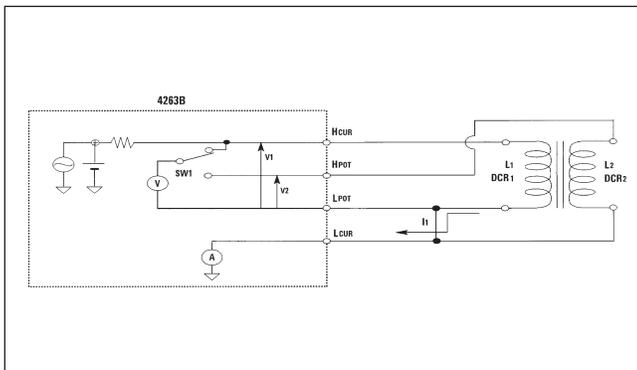


Figure 1. The 4263B block diagram for L, M, and DCR measurement

There are, however, the following limitations when using the measurement connection.

- Only primary self-inductance and dc resistance of the transformer can be measured. For the secondary values, the transformer connections must be changed.
- Turns ratio must be 0.9 or more (In the case of less than 0.9, the measurement is not performed due to saturation of internal circuitry).

The Keysight Technologies, Inc. 16060A transformer test fixture can be used to overcome these limitations. By changing the external switch of this fixture, connections to the transformer are changed and thus both primary and secondary parameters and turns ratio can easily be measured. Figure 2 shows the simple block diagram of the 16060A.

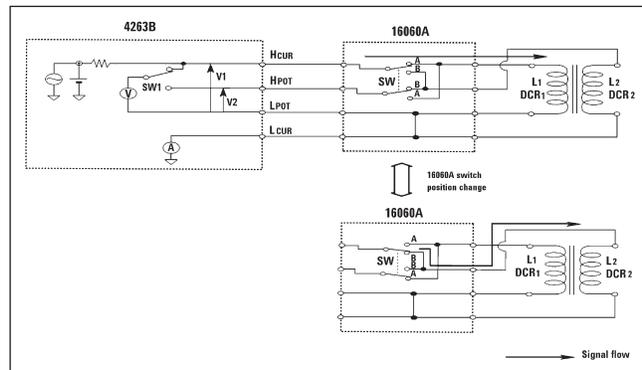


Figure 2. Keysight 16060A block diagram

Multi-Tap Transformer Measurement Using a Scanner

Multi-tap transformers having two or more poles can be measured with the 4263B and a scanner.

(A) System configuration

Figure 3 shows the system configuration for measuring a multi-tap transformer that has 4 taps.

The 3488A switch/control unit with a 4 x 4 matrix switch module (Opt. 013) is used. Option 013 offers highly flexible switching, and any combination of 4 input channels may be connected to any combination of 4 output channels. Thus option 013 is suitable for testing the multi-tap transformer. Figure 4 shows the hardware configuration of the 4 x 4 matrix switch module.

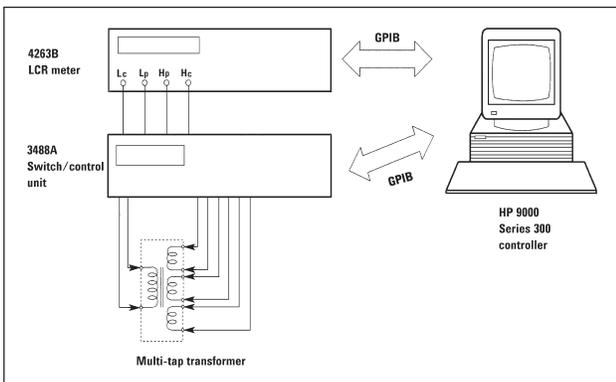


Figure 3. System configuration for multi-tap transformer

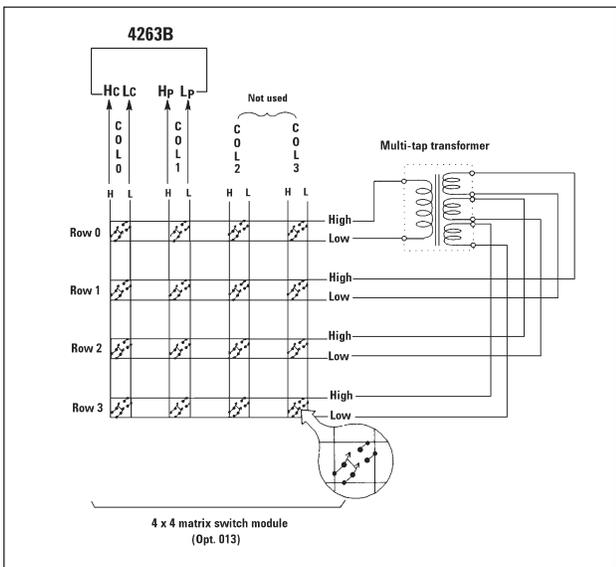


Figure 4. Option 013 4 x 4 matrix module

(B) System construction recommendations

When constructing the system, the following points must be considered to assure the measurements are as precise as can be. (See figure 5)

1. Make measurement cables as short as possible. The parasitic inductance and resistance of measurement cables make a large contribution to measurement error. For recommendable length, conductive wire inductance value must be 1/10 or less than the measured inductance value (similarly conductive wire resistance).
2. Configure into a shielded 2 terminal configuration, to prevent the influence of external noise or stray capacitance.
3. Connect the low terminals close to the transformer. In the 4263B transformer measurement, the primary and secondary inductors' low terminals of the transformer must be connected together. When using a scanner, these connections should be close to the transformer under test. If connecting at a far point from the transformer (for example, input point of scanner module), low side wire resistance would contribute to increase measurement error.

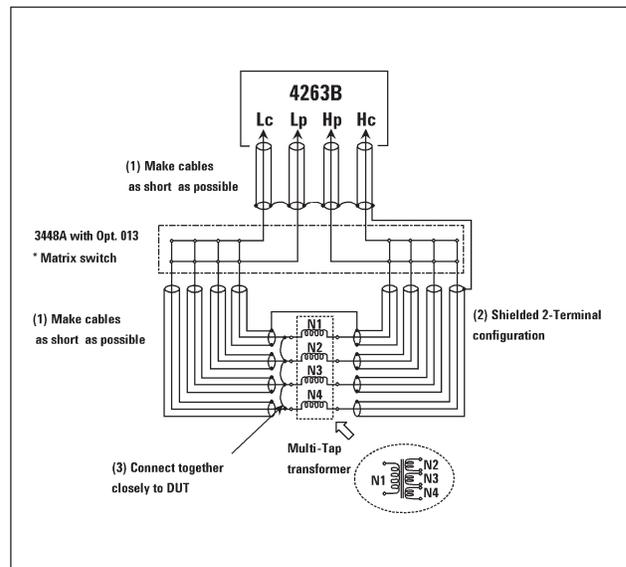


Figure 5. System construction

(C) Measurement procedure

All measurements of the multi-tap transformer, self-inductance, dc resistance, and turns ratio, can be measured with only one connection by using the sample program shown at the end of this note (for HP 9000 Series 300 Controller). Figure 6 show the flow chart of the sample program.

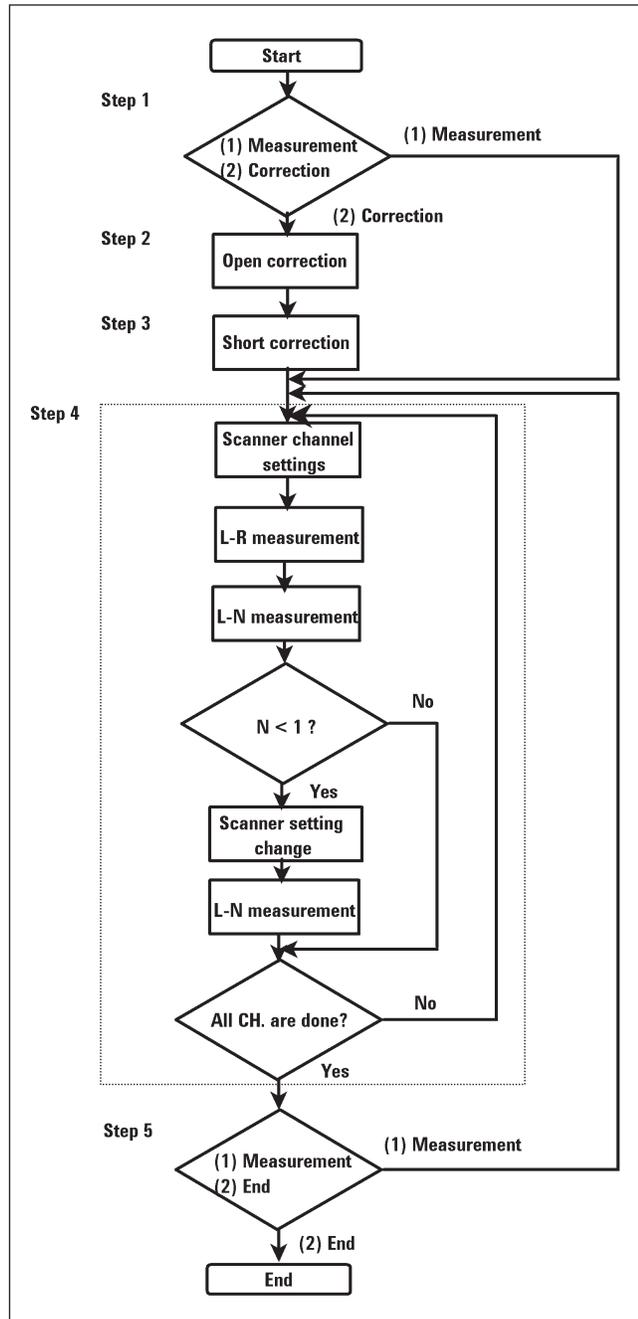


Figure 6. Flow chart of sample program

This program executes the open and short corrections and displays each measured value of each tap of the transformer. If turns ratio measurement cannot be made due to the condition that turns ratio must be 0.9 or greater, the scanner will be automatically changed and the measurements re-done. This program can be modified to match other systems or conditions.

The following steps outline the program procedure:

Step 1. Run the program. The following message is displayed on the controller’s display.

Selection (1) Measurement (2) Correction ?
Type number and press RETURN key

At this point, select the measurement directly , or first the measurement of correction data. To execute the measurement, type 1 and press RETURN key on the controller (Go to step 4). To measure the correction data, type 2 and press RETURN key on the controller.

Step 2. If the measurement of correction data in step 1 was selected, the following message is displayed on the controller’s display. The open correction data of each channel of the scanner (CH.0-CH.3) is now measured.

CH.0 Open measurement
Open test terminals of CH.0
Start open meas. (2) Skip CH.0 open meas?

Type number and press RETURN key

To measure the open correction data, set all channels to the open condition as shown in figure 7. Then, type 1 and press RETURN key on the controller. Open correction data of channel number 0 (CH.0) is acquired. Continue to acquire data for channels 1 - 3.

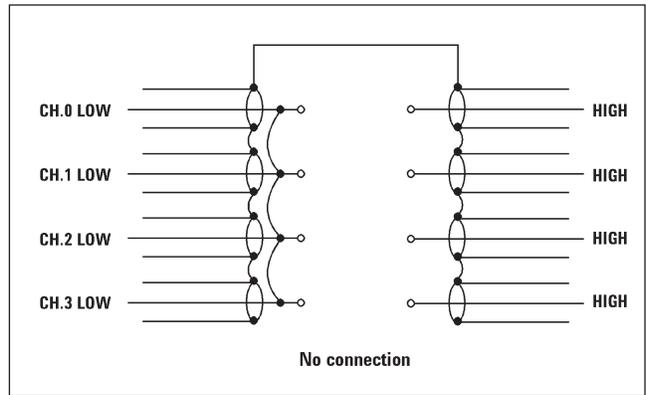


Figure 7. OPEN Condition

Step 3. After the open correction measurements are completed, the following messages is displayed on the controller's display. The short correction data of each channel of the scanner (CH.0 - CH.3) is now measured.

CH.0 Short measurement
 Short test terminals of CH.0
 Start short meas. (2) Skip CH.0 short meas.?

Type number and press RETURN key

To measure the short correction data, set all channels to short condition as shown in figure 8. Then, type 1 and press the RETURN key on the controller. Short correction data of channel number 0 (CH.0) is acquired. Continue to acquire data for channels 1 - 3.

Step 4. After the open/short correction data is acquired, the following message (same as in step 1) is displayed on the controller's display.

Selection (1) Measurement (2) Correction?
 Type number and press RETURN key

To execute the measurement, connect the multi-tap transformer under test to the scanner as shown in figure 9. Type 1 and press the RETURN key on the controller.

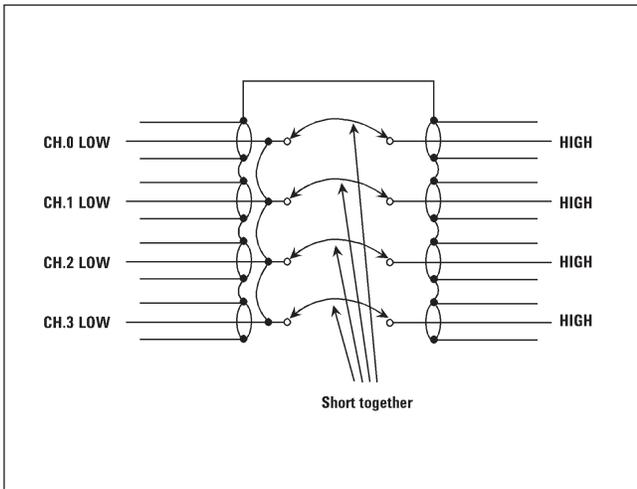


Figure 8. SHORT Condition

Self-inductance, dc resistance and turns ratio are measured by scanning each tap of the multi-tap transformer.

N1: L[H]: 6.00928E-6 DCR [OHM]: .0134568726173 N: 1
 N2: L[H]: 2.392557E-5 DCR [OHM]: .0171348134407 N: 2.1304
 N3: L[H]: 9.603832E-5 DCR [OHM]: .0230939715609 N: 4.0630
 N4: L[H]: .00038334126 DCR [OHM]: .0250939715609 N: 8.0188

Do you want to continue to measure (1) yes (2) no

Step 5. If you want to repeat the measurement, type 1 and press RETURN key on the controller. Or to end the program, type 2 and press RETURN key on the controller.

(D) Additional measurement error

The system configuration shown in figure 3, slightly increases measurement errors, in comparison with measured values using the 16060A transformer test fixture. These errors (supplemental characteristics) are the following using frequency: 1 kHz, signal level: 1 Vrms, measurement time: Medium.

Self-inductance: refer to figure 10

Dc resistance: refer to figure 11

Turns ratio: 0.02 % or less

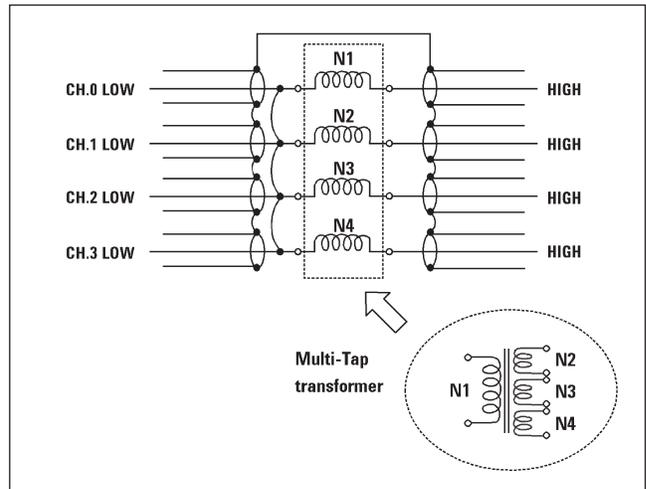


Figure 9. Connection of multi-tap transformer

Appendix. Sample Program

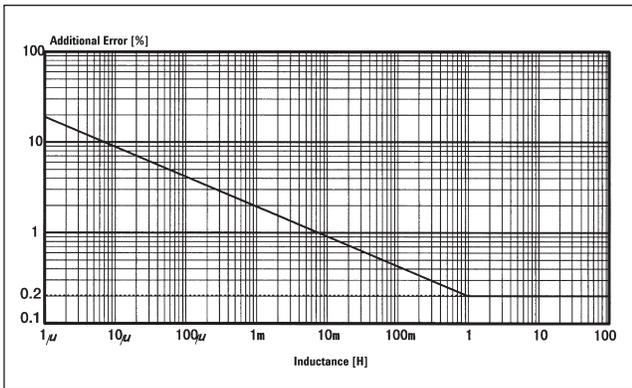


Figure 10. Self-Inductance additional error

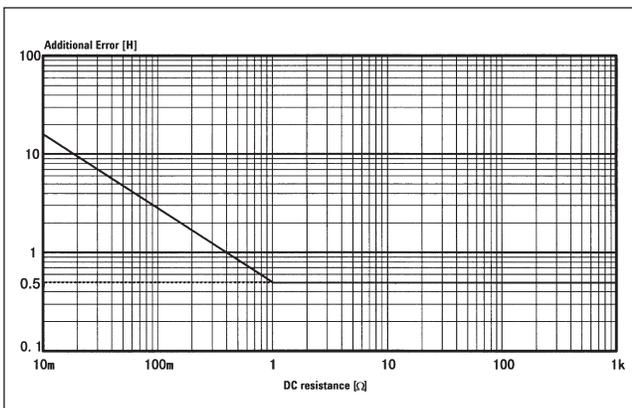


Figure 11. Dc resistance additional error

Conclusion

By combining the 4263B (with Option 001) with a scanner, the required parameters of a multi-tap transformer can be measured with only one connection. Using this method improves efficiency at the production line or incoming inspection.

```

10  |*****
20  |* 4263B with Option 001 *
30  |* Transformer Measurement using scanner *
40  |*****
50  |
60  | OPTION BASE 0
70  | DIM Ch_hc(3),Ch_hp(3)
80  | DIM Meas_r(3),Meas_l(3),Dummy(3),N(3),True_r(3),True_l(3)
90  | DIM Open_r(3),Open_l(3),Open_g(3),Open_b(3),Short_r(3),Short_l(3)
100 |
110 | 4263B=717 | 4263B GPIB Address = 717
120 | 3488a=709 | 3488A GPIB Address = 709
130 | Nch=3 | (#-1) of Transformer tap
140 | F=1.0E+3 | Test Frequency
150 | V=1 | Test Signal Level
160 | T=.065 | Measurement Speed
170 | N(0)=1 | N1=1 as reference
180 |
190 | Main_menu: | << MAIN MENU >>
200 |
210 | PRINT CHR$(12) | Clear screen
220 | Work=0
230 | PRINT "SELECT FUNCTION (1) MEASUREMENT (2) CORRECTION ?" |
240 | INPUT "TYPE NUMBER AND PRESS RETURN KEY",Work |
250 | IF Work=1 THEN Measurement
260 | IF Work=2 THEN Correction
270 |
280 | Correction: | << CORRECTION >>
290 |
300 | Open_correction: | << OPEN correction >>
310 |
320 | OUTPUT 4263B;"SYSTEM:PRESET" | Reset the 4263B
330 | OUTPUT 4263B;"SOURCE:FREQ ";F | Frequency: F
340 | OUTPUT 4263B;"SOURCE:VOLTAGE ";V | Signal level: V
350 | OUTPUT 4263B;"SENS:FIMP:APER 0.5" | Meas. speed: LONG
360 |
370 | FOR Ch=0 TO Nch
380 |
390 | Ch$=VAL$(Ch)
400 | PRINT CHR$(12)
410 | PRINT "CH."&Ch$&" OPEN MEASUREMENT"
420 | IF Ch=0 THEN PRINT "OPEN TEST TERMINALS OF CH.0 AND CH.1"
430 | IF Ch<>0 THEN PRINT "OPEN TEST TERMINALS OF CH.0 AND CH."&Ch$ |
440 | PRINT "(1) START OPEN MEAS. (2) SKIP CH."&Ch$&" OPEN MEAS.?" |
450 | Work=0
460 | INPUT "TYPE NUMBER AND PRESS RETURN KEY",Work |
470 | IF Work<>1 AND Work<>2 THEN 460
480 | IF Work=1 THEN Open_meas
490 | IF Work=2 THEN Open_skip_ch
500 |
510 | Open_meas:
520 |
530 | Ch_hc(Ch)=200+Ch*10 | Channel Setting of Hcur/Lcur
540 | IF Ch=0 THEN Ch_hp(Ch)=211 | Channel Setting of Hpot/Lcur
550 | IF Ch<>0 THEN Ch_hp(Ch)=201
560 |
570 | OUTPUT 3488a;"RESET" | Reset the 3488A
580 | OUTPUT 4263B;"CLOSE";Ch_hc(Ch),Ch_hp(Ch) | Close the channels
590 | OUTPUT 4263B;"SENS:FUNC:CONC ON" | Meas.mode: L2-R2
600 | OUTPUT 4263B;"SENS:FUNC 'IMP', 'RES'" |
610 | OUTPUT 4263B;"CALC1:FORM LS" |
620 | OUTPUT 4263B;"CALC2:FORM REAL" |
630 | OUTPUT 4263B;"TRIG:SOUR BUS" | Trigger mode: BUS
640 | OUTPUT 4263B;"*TRIG" | OPEN correction data
650 | ENTER 4263B;S_Open_l(Ch),Open_r(Ch) |
660 | IF S<>0 THEN 640
670 | OUTPUT 3488a;"OPEN";Ch_hc(Ch),Ch_hp(Ch) | Open the channels
680 | Open_g(Ch)=1/Open_r(Ch)
690 | Open_b(Ch)=1/Open_l(Ch)
700 |
710 | Open_skip_ch:
720 |
730 | NEXT Ch
740 |
750 | Short_correct: | << SHORT Correction >>
760 |
770 | OUTPUT 4263B;"SYSTEM:PRESET" | Reset the 4263B
780 | OUTPUT 4263B;"SOURCE:FREQ ";F | Frequency: F
790 | OUTPUT 4263B;"SOURCE:VOLTAGE ";V | Signal level: V
800 | OUTPUT 4263B;"SENS:FIMP:APER 0.5" | Meas. speed: LONG
810 |
820 | FOR Ch=0 TO Nch
830 |
840 | PRINT CHR$(12) | Clear screen
850 | Ch$=VAL$(Ch)
860 | PRINT "CH."&Ch$&" SHORT MEASUREMENT" |
870 | IF Ch=0 THEN PRINT "SHORT TEST TERMINALS OF CH.0 AND CH.1"
880 | IF Ch<>0 THEN PRINT "SHORT TEST TERMINALS OF CH.0 AND CH."&Ch$ |
890 | PRINT "(1) START SHORT MEAS. (2) SKIP CH."&Ch$&" SHORT MEAS.?" |
900 | Work=0
910 | INPUT "TYPE NUMBER AND PRESS RETURN KEY",Work |
920 | IF Work<>1 AND Work<>2 THEN 910
930 | IF Work=1 THEN Short_meas
940 | IF Work=2 THEN Short_skip_ch
950 |

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960 Short_meas:
970
980 Ch_hc(Ch)=200*Ch*10
990 IF Ch=0 THEN Ch_hp(Ch)=211
1000 IF Ch<>0 THEN Ch_hp(Ch)=201
1010
1020 OUTPUT 3488a;"RESET"
1030 OUTPUT 3488a;"CLOSE";Ch_hc(Ch),Ch_hp(Ch)
1040 OUTPUT 4263B;"SENS:FUNC:CONC ON"
1050 OUTPUT 4263B;"SENS:FUNC 'IMP','RES'"
1060 OUTPUT 4263B;"CALC1:FORM LS"
1070 OUTPUT 4263B;"CALC2:FORM REAL"
1080 OUTPUT 4263B;"TRIG:SOUR BUS"
1090 OUTPUT 4263B;"*TRG"
1100 ENTER 4263B;S_Short_l(Ch),Short_r(Ch)
1110 IF S<>0 THEN T0y0
1120 OUTPUT 3488a;"OPEN";Ch_hc(Ch),Ch_hp(Ch)
1130
1140 Short_skip_ch:
1150
1160 NEXT Ch
1170
1180 GOTO Main_menu
1190
1200 Measurement:
1210
1220 PRINT CHR$(12)
1230 OUTPUT 4263B;"SYSTEM:PRESET"
1240 OUTPUT 4263B;"SOURCE:FREQ ";F
1250 OUTPUT 4263B;"SOURCE:VOLTAGE ";V
1260 OUTPUT 4263B;"SENS:IMP:APER ";T
1270 OUTPUT 4263B;"TRIG:SOUR BUS"
1280 OUTPUT 3488a;"RESET"
1290
1300 FOR Ch=0 TO Nch
1310
1320 OUTPUT 4263B;"SENS:FUNC:CONC ON"
1330 OUTPUT 4263B;"SENS:FUNC 'IMP','RES'"
1340 OUTPUT 4263B;"CALC1:FORM LS"
1350 OUTPUT 4263B;"CALC2:FORM REAL"
1360 Ch_hc(Ch)=200*Ch*10
1370 IF Ch=0 THEN Ch_hp(Ch)=211
1380 IF Ch<>0 THEN Ch_hp(Ch)=201
1390 OUTPUT 3488a;"CLOSE";Ch_hc(Ch),Ch_hp(Ch)
1400 OUTPUT 4263B;"*TRG"
1410 ENTER 4263B;S_Meas_l(Ch),Meas_r(Ch)
1420 True_l(Ch)=(Meas_l(Ch)-Short_l(Ch))/((1-(Meas_l(Ch)-Short_l(Ch))*Open_b(Ch)))
1430 True_r(Ch)=(Meas_r(Ch)-Short_r(Ch))/((1-(Meas_r(Ch)-Short_r(Ch))*Open_g(Ch)))
1440
1450 IF Ch=0 THEN Skip_meas
1460
1470 OUTPUT 4263B;"SENS:FUNC 'IMP','VOLT:AC"
1480 OUTPUT 4263B;"*TRG"
1490 ENTER 717;S_Dummy(Ch),N(Ch)
1500
1510 IF S=1 THEN
1520 OUTPUT 3488a;"OPEN";Ch_hc(Ch),Ch_hp(Ch)
1530 Ch_hc(Ch)=201*Ch*10
1540 Ch_hp(Ch)=200
1550 OUTPUT 3488a;"CLOSE";Ch_hc(Ch),Ch_hp(Ch)
1560 OUTPUT 4263B;"*TRG"
1570 ENTER 4263B;S_Dummy(Ch),N(Ch)
1580 N(Ch)=N(0)/N(Ch)
1590 END IF
1600
1610 Skip_meas:
1620
1630 PRINT "N";Ch+1;" ";L [H]:";True_l(Ch) "DCR [OHM]:";True_r(Ch) "N:";N(Ch)
1640 OUTPUT 3488a;"OPEN";Ch_hc(Ch),Ch_hp(Ch)
1650
1660 NEXT Ch
1670
1680 Work=0
1690 INPUT "DO YOU WANT TO CONTINUE TO MEASURE? (1) YES (2) NO";Work
1700 IF Work=1 THEN Measurement
1710 IF Work=2 THEN 1740
1720 IF Work<>1 AND Work<>2 THEN 1690
1730
1740 END

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This document was formerly known as Application Note 1224-5

